Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
S73	2	"20020070738"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/03/07 09:29
S74	5	"6559662"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/03/07 09:29
S75	9	("4417203" | "4980639" | "5680056" | "5804980" | "5877498" | "6005400" | "6177681" | "6232787" | "6323484").PN.	USPAT	OR	OFF	2005/03/07 09:29
S76	3625	(electron adj beam$1) and (contact adj (hole$1 or opening$1))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/03/07 09:29
S77	62	((electron adj beam$1) and (contact adj (hole$1 or opening$1))) and (yamada.in.)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/03/07 09:29
S78	90	((electron adj beam$1) and (contact adj (hole$1 or opening$1))) and scribe	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/03/07 09:29
S79	90	((electron adj beam$1) and (contact adj (hole$1 or opening$1))) and auger	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/03/07 09:29
S80	2874	((electron adj beam$1) and (contact adj (hole$1 or opening$1))) and (electromagnetic or light$1 or laser)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/03/07 09:29
S81	90	((electron adj beam$1) and (contact adj (hole$1 or opening$1))) and auger	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/03/07 09:29

S82	62	((electron adj beam$1) and (contact adj (hole$1 or opening$1))) and (electromagnetic or light$1 or laser) and auger	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/03/07 09:29
S83	2	"20040031932"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/07 09:29
S84	2	"20030146381"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/07 09:29
S85	133	(electron adj beam) and (remove same residue same beam)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/07 09:29
S86	404	(electron adj beam) and semiconductor and repair and test	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/07 09:29
S87	298	(electron adj beam) and semiconductor and fault and correction	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/07 09:29
S88	320	(electron adj beam) and default and correction	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/07 09:29
S89	552	(electron adj beam) and (correction adj process$4)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/07 09:29
S90	114	S89 and "250"/$.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/07 09:29
S91	6	("20030132381" | "20030132765" | "5162240" | "5376215" | "5427052" | "6306001").PN.	US-PGPUB; USPAT; USOCR	OR	ON	2005/03/07 09:29

S92	24827422	"1" or "2" or "3" or "5" or "7" or "9" or "10" or "12" or "13" or "14" or "15" or "16" or "17" or "18" or "19" or "20"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/07 09:29
S93	59436	"21" and photoresist	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/07 09:29
S94	3625	(electron adj beam$1) and (contact adj (hole$1 or opening$1))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/03/07 09:29
S95	2874	((electron adj beam$1) and (contact adj (hole$1 or opening$1))) and (electromagnetic or light$1 or laser)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/03/07 09:29
S96	90	((electron adj beam$1) and (contact adj (hole$1 or opening$1))) and auger	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/03/07 09:29
S97	2	"20020070738"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/03/07 09:29
S98	5	"6559662"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/03/07 09:29
S99	90	((electron adj beam$1) and (contact adj (hole$1 or opening$1))) and auger	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/03/07 09:29
S100	62	((electron adj beam$1) and (contact adj (hole$1 or opening$1))) and (electromagnetic or light$1 or laser) and auger	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/03/07 09:29
S101	2	"20030146381"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/07 09:29

S10 2	133	(electron adj beam) and (remove same residue same beam)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/07 09:29
S10 3	404	(electron adj beam) and semiconductor and repair and test	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/07 09:29
S10 4	298	(electron adj beam) and semiconductor and fault and correction	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/07 09:29
S10 5	320	(electron adj beam) and default and correction	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/07 09:29
S10 6	552	(electron adj beam) and (correction adj process$4)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/07 09:29
S10 7	114	S106 and "250"/$.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/07 09:29
S10 8	6	("20030132381" | "20030132765" | "5162240" | "5376215" | "5427052" | "6306001").PN.	US-PGPUB; USPAT; USOCR	OR	ON	2005/03/07 09:29
S10 9	4179	S97 or S98 or S99 or S95 or S96 or S100 or S101 or S102 or S103 or S104 or S105 or S106 or S107 or S108	US-PGPUB; USPAT; USOCR	OR	ON	2005/03/07 09:29
S11 0	2	"20020070738"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/03/07 09:29
S11 1	5	"6559662"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/03/07 09:29

S11 2	9	("4417203" | "4980639" | "5680056" | "5804980" | "5877498" | "6005400" | "6177681" | "6232787" | "6323484").PN.	USPAT	OR	OFF	2005/03/07 09:29
S11 3	62	((electron adj beam$1) and (contact adj (hole$1 or opening$1))) and (yamada.in.)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/03/07 09:29
S11 4	90	((electron adj beam$1) and (contact adj (hole$1 or opening$1))) and scribe	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/03/07 09:29
S11 5	90	((electron adj beam$1) and (contact adj (hole$1 or opening$1))) and auger	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/03/07 09:29
S11 6	62	((electron adj beam$1) and (contact adj (hole$1 or opening$1))) and (electromagnetic or light$1 or laser) and auger	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/03/07 09:29
S11 7	2	"20040031932"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/07 09:29
S11 8	2	"20030146381"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/07 09:29
S11 9	6	("20030132381" | "20030132765" | "5162240" | "5376215" | "5427052" | "6306001").PN.	US-PGPUB; USPAT; USOCR	OR	ON	2005/03/07 09:29
S12 0	133	(electron adj beam) and (remove same residue same beam)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/07 09:29
S12 1	114	S106 and "250"/$.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/07 09:29

S12 2	298	(electron adj beam) and semiconductor and fault and correction	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/07 09:29
S12 3	320	(electron adj beam) and default and correction	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/07 09:29
S12 4	404	(electron adj beam) and semiconductor and repair and test	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/07 09:29
S12 5	552	(electron adj beam) and (correction adj process$4)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/07 09:29
S12 6	2	"20020070738"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/03/07 09:29
S12 7	5	"6559662"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/03/07 09:29
S12 8	90	((electron adj beam$1) and (contact adj (hole$1 or opening$1))) and auger	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/03/07 09:29
S12 9	2874	((electron adj beam$1) and (contact adj (hole$1 or opening$1))) and (electromagnetic or light$1 or laser)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/03/07 09:29
S13 0	90	((electron adj beam$1) and (contact adj (hole$1 or opening$1))) and auger	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/03/07 09:29
S13 1	62	((electron adj beam$1) and (contact adj (hole$1 or opening$1))) and (electromagnetic or light$1 or laser) and auger	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/03/07 09:29

S13 2	2	"20030146381"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/07 09:29
S13 3	133	(electron adj beam) and (remove same residue same beam)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/07 09:29
S13 4	404	(electron adj beam) and semiconductor and repair and test	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/07 09:29
S13 5	298	(electron adj beam) and semiconductor and fault and correction	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/07 09:29
S13 6	320	(electron adj beam) and default and correction	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/07 09:29
S13 7	552	(electron adj beam) and (correction adj process$4)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/07 09:29
S13 8	114	S137 and "250"/$.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/07 09:29
S13 9	6	("20030132381" | "20030132765" | "5162240" | "5376215" | "5427052" | "6306001").PN.	US-PGPUB; USPAT; USOCR	OR	ON	2005/03/07 09:29
S14 0	4179	S126 or S127 or S128 or S129 or S130 or S131 or S132 or S133 or S134 or S135 or S136 or S137 or S138 or S139	US-PGPUB; USPAT; USOCR	OR	ON	2005/03/07 09:29
S14 1	1651	S140 and photoresist	US-PGPUB; USPAT; USOCR	OR	ON	2005/03/07 09:29
S14 2	2785	250/310	US-PGPUB; USPAT; USOCR	OR	ON	2005/03/07 09:29
S14 3	2176	250/311	US-PGPUB; USPAT; USOCR	OR	ON	2005/03/07 09:29

S14 4	1409	250/491.1	US-PGPUB; USPAT; USOCR	OR	ON	2005/03/07 09:29
S14 5	2765	250/492.1	US-PGPUB; USPAT; USOCR	OR	ON	2005/03/07 09:29
S14 6	4265	250/492.2	US-PGPUB; USPAT; USOCR	OR	ON	2005/03/07 09:29
S14 7	1388	250/492.21	US-PGPUB; USPAT; USOCR	OR	ON	2005/03/07 09:29
S14 8	1146	250/492.22	US-PGPUB; USPAT; USOCR	OR	ON	2005/03/07 09:29
S14 9	2553	324/537	US-PGPUB; USPAT; USOCR	OR	ON	2005/03/07 09:29
S15 0	612	324/751	US-PGPUB; USPAT; USOCR	OR	ON	2005/03/07 09:29
S15 1	826	324/500	US-PGPUB; USPAT; USOCR	OR	ON	2005/03/07 09:29
S15 2	573	324/501	US-PGPUB; USPAT; USOCR	OR	ON	2005/03/07 09:29
S15 3	1345	324/522	US-PGPUB; USPAT; USOCR	OR	ON	2005/03/07 09:29
S15 4	65	S140 and ("324"/$.ccls.)	US-PGPUB; USPAT; USOCR	OR	ON	2005/03/07 09:29
S15 5	457	S140 and "250"/$.ccls.	US-PGPUB; USPAT; USOCR	OR	ON	2005/03/07 09:29
S15 6	6	("20030132381" | "20030132765" | "5162240" | "5376215" | "5427052" | "6306001").PN.	US-PGPUB; USPAT; USOCR	OR	ON	2005/03/07 09:55
S15 7	0	"kadyshevitch.in",	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/07 10:56
S15 8	0	"kadyshevitch.in."	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/07 10:56

S159	17	kadyshevitch.in.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/03/07 10:56